

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/629,591	FUJITA, SHIN	
Examiner		Art Unit		Page 1 of 1
Tom V. Sheng		2677		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,362,643	03-2002	Kim, Seong Gyun	324/770
*	B	US-6,747,624	06-2004	Udo et al.	345/89
*	C	US-2003/0142053	07-2003	Kumagai et al.	345/87
*	D	US-2003/0231734	12-2003	Fujita et al.	377/64
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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